

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination TAKEI ET AL.	
		Examiner Vivian Chen	Art Unit 1773	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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	N	JP 2002-327124	11-2002	JP	Takei et al.	
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NON-PATENT DOCUMENTS

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